

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10800073	BANEY ET AL.
	Examiner	Art Unit
	Hanh Phan	2613

SEARCHED

Class	Subclass	Date	Examiner
398	202, 203, 204, 205, 206, 207, 208, 209, 213, 214	08/16/2008	HP
356	484, 451, 477, 73.1	08/16/2008	HP
250	214R, 227.43, 227.19, 227.17	08/16/2008	HP
UPDATE SEARCH		08/16/2008	HP

SEARCH NOTES

Search Notes	Date	Examiner
EAST SEARCH SEE ATTACHED PRINTOUT IN THE FILE	08/16/2008	HP
JPO SEARCH	08/16/2008	HP
IEEE SEARCH	08/16/2008	HP
PG PUB TEXT SEARCH SEE INTERFERENCE SEARCH PRINTOUT	08/16/2008	HP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
398	202, 203, 204, 205, 206, 207, 208, 209, 213, 214	08/16/2008	HP
356	484, 451, 477, 73.1	08/16/2008	HP
250	214R, 227.43, 227.19, 227.17	08/16/2008	HP

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